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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/605,082	09/08/2003	MIN-LUNG HUANG	10228-US-PA	2081
31561	7590 11/23/2004	•	EXAM	INER
JIANQ CHYUN INTELLECTUAL PROPERTY OFFICE			TSAI, H JEY	
7 FLOOR-1, NO. 100 ROOSEVELT ROAD, SECTION 2 TAIPEI, 100			ART UNIT	PAPER NUMBER
			2812	
TAIWAN			DATE MAILED: 11/23/2004	1

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)			
	10/605,082	HUANG ET AL.			
Office Action Summary	Examiner	Art Unit			
	H.Jey Tsai	2812			
The MAILING DATE of this communication app Period for Reply	ears on the cover sheet with the c	orrespondence address			
A SHORTENED STATUTORY PERIOD FOR REPLY THE MAILING DATE OF THIS COMMUNICATION.  - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication.  - If the period for reply specified above is less than thirty (30) days, a reply If NO period for reply is specified above, the maximum statutory period w Failure to reply within the set or extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	36(a). In no event, however, may a reply be timed within the statutory minimum of thirty (30) day will apply and will expire SIX (6) MONTHS from a cause the application to become ABANDONE	nely filed s will be considered timely. the mailing date of this communication. D (35 U.S.C. § 133).			
Status					
1) Responsive to communication(s) filed on 24 Se	eptember 2004.				
3) Since this application is in condition for allowar	<i>,</i> —				
Disposition of Claims					
4) ☐ Claim(s) 9 and 11-16 is/are pending in the app 4a) Of the above claim(s) is/are withdray 5) ☐ Claim(s) is/are allowed. 6) ☐ Claim(s) 9, 11-16 is/are rejected. 7) ☐ Claim(s) is/are objected to. 8) ☐ Claim(s) are subject to restriction and/or	vn from consideration.				
Application Papers					
9) The specification is objected to by the Examine	r.				
10) The drawing(s) filed on is/are: a) accepted or b) objected to by the Examiner.					
Applicant may not request that any objection to the	drawing(s) be held in abeyance. See	e 37 CFR 1.85(a).			
Replacement drawing sheet(s) including the correct		•			
11) The oath or declaration is objected to by the Ex	aminer. Note the attached Office	Action or form PTO-152.			
Priority under 35 U.S.C. § 119					
12) Acknowledgment is made of a claim for foreign a) All b) Some * c) None of:  1. Certified copies of the priority documents 2. Certified copies of the priority documents 3. Copies of the certified copies of the prior application from the International Bureau * See the attached detailed Office action for a list	s have been received. s have been received in Applicati ity documents have been receive I (PCT Rule 17.2(a)).	on No ed in this National Stage			
Attachment(s)	_				
1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948)	4) Interview Summary Paper No(s)/Mail Da				
<ol> <li>Notice of Draftsperson's Patent Drawing Review (PTO-948)</li> <li>Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)         Paper No(s)/Mail Date     </li> </ol>		ratent Application (PTO-152)			

## Claim Rejections - 35 USC § 112

The following is a quotation of the second paragraph of 35 U.S.C. 112:

The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.

Claims 9, 11-16 recites the limitation "UBM". There is insufficient antecedent basis for this limitation in the claim. Changing "under-bump-metallurgy" to "under-bump-metallurgy (UBM)" in claims 9 and 13 is suggested.

## Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 9, 12-13 and 15-16 are rejected under 35 U.S.C. 103(a) as being unpatentable over Ratificar et al. 2003/0121958 in view of Kunimatsu et al. 5,767,564 and Nguyen et al. 6,238,949, all are previously cited.

The reference(s) teach the features:

a die 100 having an active surface and a back surface wherein the active surface is implemented with a plurality of bonding pads 110, fig. 1a and para. 14+,

an under-bump-metallurgy layer 130 disposed over the bonding pads 110, para.

a patterned dielectric layer 120 over the active surface of the die, wherein the patterned dielectric layer 120 has a plurality of openings 125 that expose the bonding pads 110 and the UBM layer is disposed above the patterned dielectric layer, fig. 1b,

a plurality of solder blocks 150, respectively disposed above the under-bump metallurgy layer 130,

a passive component 170 (a substrate that includes passive electronic components, para. 13) having a plurality of terminal electrodes, para. 26,

the terminal electrodes 160/172 are respectively coupled to the UBM layer through the solder blocks 150/155.

Kunimatsu et al. substantially discloses a chip structure and a chip package structure, which includes :

a substrate 1 (called package) having an upper surface, fig. 1+ and col. 3, lines 34+,

a die 2 (called semiconductor element) having an active surface and a back surface, wherein the back surface of the die 2 is in contact with the upper surface of the substrate 1 (called package) and the active surface is implemented with a plurality of bonding pads, see fig. 2-3, and col. 4, lines 13+,

a solder block 3A disposed on the die 2, figs. 2-3 and col. 4, lines 32+,

a passive component 3 (a capacitor) with a plurality of terminal electrodes 5, 7, 8 wherein the terminal electrodes are coupled to the solder block 3A, col. 4, lines 38+,

a plurality of conductive wires electrically connecting the die 2 and the substrate

Nguyen et al. teaches at col. 1, lines 15-22, col. 3, lines 34-38 using a plastic as an encapsulant for a chip package.

The difference between the reference(s) and the claims are as follows: Ratifiecar et al. teaches mounting a substrate that can be a passive component of capacitor to a die through a UBM layer to the solder block but does not teach that at least two terminal electrodes are respectively disposed at two ends of the passive component and using plastic to encapsulate the die. However, Kunimatsu et al. teaches at figs. 1-5, two terminal electrodes 3A are respectively disposed at two ends of the passive component 3. And, Nguyen et al. teaches at col. 1, lines 15-22, col. 3, lines 34-38 using a plastic as encapsulant to form a packaged integrated circuit.

It would have been obvious to one having ordinary skill in the art at the time the invention was made to have modified Ratificar et al.'s process with two terminal electrodes are respectively disposed at two ends of the passive component as suggested by Kunimatsu et al. because there must have two terminal electrodes as input and output terminals of a passive electronic component to be functional and using a plastic package as suggested by Nguyen et al. because plastic package is less expensive than other type of chip package.

Claims 11 and 14 are rejected under 35 U.S.C 103 as being unpatentable over Ratificar et al. in view of Kunimatsu et al. and Nguyen et al. as applied to claims 9, 12-13 and 15-16 above, and further in view of Lin 6,303,423.

The difference between the references applied above and the instant claim(s) is: Primary reference Ratificar et al. in view of Kunimatsu et al. and Nguyen et al. does not teach a re-distribution layer is connected to the bond pad. However, Lin '423 teach at

col. 7, lines 37-53 and figure 4 and 11 that a network of electrical connections formed from conductive line 13 is connected to bonding pad 16.

It would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the above references' teachings with a re-distribution layer as taught by Lin '423 because passive component formed over the die can be re-distribute to the circuit formed in the die.

## Conclusion

In view of the response and English translation filed on Sept. 24, 2004, the rejection of claims 9-16 over Kwon 2004/0012081 and rejection of claims 9-11 over Lin 2004/0029404 are withdrawn.

Applicant's arguments filed Sept. 24, 2004 have been fully considered but they are not persuasive. Because Ratificar et al. clearly teaches a patterned dielectric layer 120 over the active surface of the die, wherein the patterned dielectric layer 120 has a plurality of openings 125 that expose the bonding pads 110 and the UBM layer is disposed above the patterned dielectric layer, fig. 1b, a plurality of solder blocks 150, respectively disposed above the under-bump metallurgy layer 130, a passive component 170 (a substrate that includes passive electronic components, para. 13) having a plurality of terminal electrodes coupled to the UBM layer through the solder blocks 150/155 as set forth above. And, Kunimatsu et al. clearly teaches at figs. 1-5, a passive electronic component must have two terminal electrode for input and output to be functional, the two terminal electrodes 3A are respectively disposed at two ends of the passive component 3.

Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

Any inquiry of a general nature or clerical matters or relating to the status of this application or proceeding should be directed to the Group customer service whose telephone number is 571-272-1626 and Fax number (703) 872-9306.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to H. Jey Tsai whose telephone number is (571) 272-1684. The examiner can normally be reached on from 7:00 Am to 4:00 Pm., Monday thru Friday.

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, John Niebling can be reached on (571) 272-1679. The fax phone number for this Group is (703) 872-9306.

hjt

11/15/04

H. Jey Tsai Primary Examiner

Patent Examining Group 2800

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